TOSHIBA PHOTOCOUPLER GaAlAs IRED & PHOTO-IC

TLP706

Intelligent power module signal isolation Industrial inverters Motor drive

The Toshiba TLP706 consists of a GaAlAs light-emitting diode and an integrated high-gain, high-speed photodetector. The TLP706 is suitable for isolating input control signals to intelligent power modules. This unit is a 6-pin SDIP. The TLP706 is 50% smaller than the 8-PIN DIP and meets the reinforced insulation class requirements of international safety standards. Therefore the mounting area can be reduced in equipment requiring safety standard certification.

The detector has a totem pole output stage to provide both source and sink driving. The detector IC has an internal shield that provides a guaranteed common-mode transient immunity of 10 kV/ μ s.

The TLP706 is buffer logic type. For inverter logic type, the TLP702 is in line-up.

- Buffer logic type (totem pole output)
- Pb Free
- Guaranteed performance over temperature : −40~100°C
- Power supply voltage: 4.5~20 V
- Input current: IFHL = 5 mA (Max.)
- Switching time (t_{pLH} / t_{pHL}): 600 ns (Max.)
- Common-mode transient immunity: ±10 kV/µs (Min)
- Isolation voltage : 5000 Vrms (Min)
- UL Recognized :UL1577, File No.E67349
- Option (D4)

TÜV Approved : DIN EN60747-5-2 No.R50033433

Maximum Operating Insulation Voltage: 890V_{PK} Highest Permissible Over Voltage: 8000V_{PK}

(Note) : When a EN60747-5-2 approved type is needed, Please designate "Option(D4)"

Construction Mechanical Rating

	7.62 mm pich standard type	10.16 mm pich TLPXXXF type
Creepage Distance	7.0 mm (Min)	8.0 mm (Min)
Clearance	7.0 mm (Min)	8.0 mm (Min)
Insulation Thickness	0.4 mm (Min)	0.4 mm (Min)

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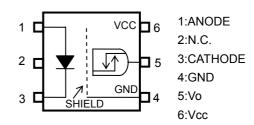
Truth Table

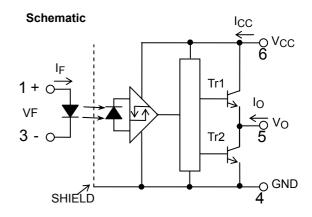
Input	LED	Tr1	Tr2	Output
Н	ON	ON	OFF	Н
L	OFF	OFF	ON	L

Unit in mm 4.58±0.25 6 5 4 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 99 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1 2 3 97 1

Weight: 0.26 g (typ.)

Pin Configuration (Top View)





 $0.1~\mu F$ bypass capacitor must be connected between pins 6 and 4. (Note 4)

Absolute maximum ratings (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	RATING	UNIT
	Forward Current (Ta ≤ 85°C)	lF	20	mA
	Forward Current Derating (Ta > 85°C)	ΔΙ _Ε /ΔΤα	-0.5	mA/°C
LED	Peak Transient Forward Current (Note 1)	IFPT	1	Α
	Reverse Voltage		5	٧
	Junction Temperature	Tj	125	°C
	Output Current 1 (Ta ≤ 25°C)	l ₀₁	15/-15	mA
	Output Current 2 (Ta ≤ 100°C)	I _{O2}	4.5/-4.5	mA
DETECTOR	Peak Output Current		20/-20	mA
DETE	Output Voltage	VO	-0.5~20	V
	Supply Voltage	V _{CC}	-0.5~20	V
	Junction Temperature	Tj	125	°C
Oper	ating Temperature Range	Topr	-40~100	°C
Stora	ge Temperature Range	Tstg	-55~125	°C
Lead	Solder Temperature (10 s)	Tsol	260	°C
Isolat	tion Voltage (AC,1 min., R.H. ≤ 60%, Ta = 25°C) (Note 2)	BVs	5000	Vrms

Recommended Operating Conditions

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Input Current, ON	IF (ON)	7	-	12	mA
Input Voltage, OFF	VF (OFF)	0	-	0.8	V
Supply Voltage (*) (Note 3, Note 4)	Vcc	4.5	-	20	V

Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

(*) This item denotes operating ranges, not meaning of recommended operating conditions.

Note1 : Pulse width PW≤1us,300pps.

Note2 : Device Considered a two terminal device : pins 1,2 and 3 shorted together and pins 4,5 and 6 shorted together.

Note3 :The detector of this product requires a power supply voltage (VCC) of 4.5 V or higher for stable operation.

If the VCC is lower than this value, an output may be unstable. Be sure to use the product after checking the supply current, and the operation of a power-on/-off.

Note4 : A ceramic capacitor($0.1~\mu F$) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

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Electrical Characteristics (Unless otherwise specified, Ta =-40~100°C, Vcc = 4.5~20 V.)

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	C	TIDNC	TON	MIN.	TYP. *	MAX.	UNIT
Input forward voltage	V_{F}	_	I _F = 5 mA , Ta = 25°C		_	1.6	1.7	V	
Temperature coefficient of forward voltage	ΔV _F /ΔTa	_	I _F = 5 mA			_	-2.0	_	mV/°C
Input reverse current	I_{R}	_	V _R = 5 V ,	Ta = 2	5°C	_	_	10	μΑ
Input capacitance	CT	_	V = 0 V, f =	1 MH	z, Ta = 25°C	_	30	_	pF
Logic LOW output voltage	V _{OL}	1	I _{OL} = 3.5 n	I _{OL} = 3.5 mA , V _F = 0.8 V		_	0.1	0.35	V
	.,		I _{OH} = -3.5	mA,	V _{CC} = 5 V	2.4	3.1	_	
Logic HIGH output voltage	Vон	2	I _F = 5 mA		V _{CC} = 20 V	17.4	18.1	_	V
Laria LOW averally average		2	V _{CC} = 20 Ta =-40~1		= 20 V -40~100°C	_	4.0	6.0	mA
Logic LOW supply current	ICCL	3	v _F = 0 v	$V_F = 0 V$ V_{CC} $Ta = 1$		_	3.6	4.5	
		_			= 20 V -40~100°C	_	3.1	6.0	
Logic HIGH supply current	ICCH	4	$I_F = 5 \text{ mA}$	V _{CC} Ta = 1	= 5 V 25°C	_	2.8	4.5	mA
Logic LOW short circuit output current	lost	5	V _F = 0.8 V V _{CC} = V _O			7	37	1	mA
Logic HIGH short circuit output current	Iosh	6	$I_F = 5 \text{ mA}, V_O = \text{GND}$ $V_{CC} = 20 \text{ V}$		-7	-40	1	mA	
Input current logic HIGH output	lFLH	_	$I_O = -3.5 \text{ mA}, V_O > 2.4V$ $V_{CC} = 5 \text{ V}$		_	0.5	5	mA	
Input voltage logic LOW output	V_{FHL}	_	I _O = 3.5 mA, V _O < 0.4 V		0.8	_	_	V	
Input current hysteresis	lHYS	_	V _{CC} = 5 V			_	0.05	_	mA

^{*}All typical values are at Ta = 25°C.

Isolation Characteristics (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Capacitance input to output	CS	V = 0V, f = 1 MHz (Note 2)	_	1.0	_	pF
Isolation resistance	R _S	R.H. ≤ 60%, V _S = 500 V (Note 2)	1×10 ¹²	10 ¹⁴	_	Ω
		AC, 1 minute	5000	_	_	V _{rms}
Isolation voltage	BV_S	AC, 1 second, in oil	_	10000	_	Vdc
		DC, 1 minute, in oil	_	10000	_	vuc

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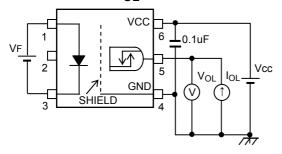
Switching Characteristics

(Unless otherwise specified, $Ta = -40 \sim 100^{\circ}\text{C}$, $Vcc = 4.5 \sim 20 \text{ V.}$)

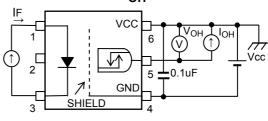
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CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION	MIN.	TYP. *	MAX.	UNIT
Propagation delay time to logic HIGH output	^t pLH		$I_F = 0 \rightarrow 5 \text{ mA}, C_L = 100 \text{ pF}$ $V_{CC} = 20 \text{ V}$	50	250	600	ns
Propagation delay time to logic LOW output	^t pHL		$I_F = 5 \rightarrow 0 \text{ mA}, C_L = 100 \text{ pF}$ $V_{CC} = 20 \text{ V}$	50	260	600	ns
Switching time dispersion Between ON and OFF	lt _{pHL} - t _{pLH} l	7	$I_F = 0$ 5 mA, $C_L = 100 pF$ $V_{CC} = 20 V$	I	ı	550	ns
Output rise time	tr		I _F = 0→5 mA, V _{CC} = 20 V	ı	175	ı	ns
Output fall time	tf		I _F = 5→0 mA, V _{CC} = 20 V	1	95		ns
Propagation delay time to logic HIGH output	t _{pLH}		I _F = 0→5 mA	50	_	600	ns
Propagation delay time to logic LOW output	^t pHL	8	I _F = 5→0 mA	50	1	600	ns
Common-mode transient Immunity at LOW level output	CML		$V_{CM} = 1000 \text{ Vp-p}, I_F = 0 \text{ mA},$ $V_{CC} = 20 \text{ V}, \text{ Ta} = 25^{\circ}\text{C}$	10000		_	V/us
Common-mode transient Immunity at HIGH level output	СМН	9	V _{CM} = 1000 Vp-p, I _F = 5 mA, V _{CC} = 20 V, Ta = 25°C	-10000	-	_	V/us

^{*}All typical values are at Ta = 25°C.

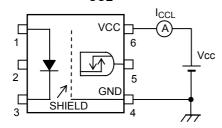
TEST CIRCUIT 1: VOL



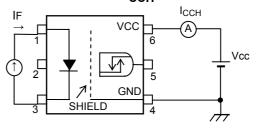
TEST CIRCUIT 2: VOH



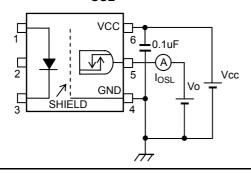
TEST CIRCUIT 3: ICCL



TEST CIRCUIT 4 : I_{CCH}

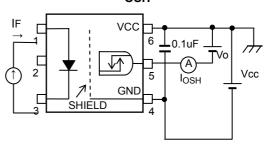


TEST CIRCUIT 5: IOSL

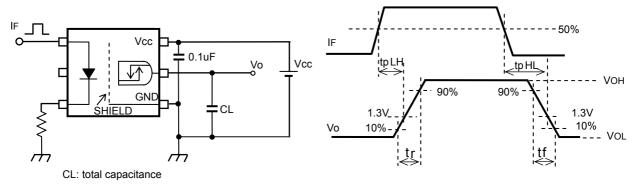


TEST CIRCUIT 6: IOSH

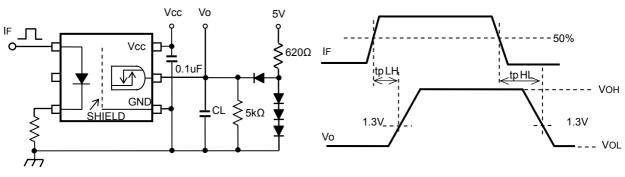
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TEST CIRCUIT 7: Switching Time Test Circuit

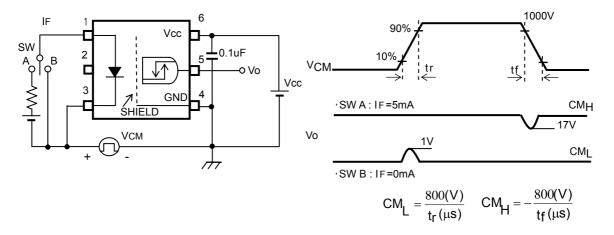


TEST CIRCUIT 8: Switching Time Test Circuit



CL: stray capacitance of probe and wiring (to 15 pF)

TEST CIRCUIT 9: Common-Mode Transient Immunity Test Circuit



 CM_L (CM_H) is the maximum rate of rise (fall) of the common mode voltage that can be sustained with the output voltage in the low (high) state.

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